

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re the Rule 1.53(b) Divisional Application of:

ODA, Shunri et al.

Group Art Unit: **2814** (expected)

Serial No.: Not yet assigned

Examiner: **NGO, Ngan V.** (expected)

Filed: **September 23, 2003**

For. **MICRO ELECTRON GUN OF QUANTUM SIZE EFFECT TYPE AND FLAT DISPLAY USING SUCH ELECTRON GUNS AS WELL AS METHODS OF THEIR MANUFACTURE**

INFORMATION DISCLOSURE STATEMENT
PURSUANT TO 37 CFR 1.97(b)

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

September 23, 2003

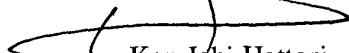
Sir:

This Information Disclosure Statement is being filed in order to comply with Applicant's duty of disclosure under 37 CFR 1.56. The documents listed on the Form PTO-1449 were made of record in parent application Serial No. 10/275,959.

The Commissioner is authorized to charge our Deposit Account No. 01-2340 for any fee which is deemed by the Patent and Trademark Office to be required to effect consideration of this statement.

Respectfully submitted,

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PATENT TRADEMARK OFFICE

Enclosure: PTO-1449

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| INFORMATION DISCLOSURE CITATION PTO-1449 | Atty. Docket No. 021498A | Serial No. Not yet assigned |
| | Applicant(s): ODA, Shunri, et al. | |
| | Filing Date: September 17, 2003 | Group Art Unit: 2814 |

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| Examiner _____ | | Date Considered _____ |